Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination		
10/658,228	CHEN, YUN-LUNG		
Examiner	Art Unit		
Hanh V. Tran	3637		

SEARCHED				
Class	Subclass	Date	Examiner	
312	265.5	12/5/2005	HVT	
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Class	Subclass	Date	Examiner	
	1			

SEARCH NO (INCLUDING SEARCH	TES STRATEGY	)
	DATE	EXMR
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